PCTEST

PCTEST ENGINEERING LABORATORY, INC.

6660-B Dobbin Road, Columbia, MD 21045 USA Tel. 410.290.6652 / Fax 410.290.6554 http://www.pctestlab.com



HEARING AID COMPATIBILITY

Applicant Name:

LG Electronics MobileComm U.S.A., Inc. 1000 Sylvan Avenue Englewood Cliffs, NJ 07632 United States Date of Testing:

5/29/2012

Test Site/Location:

PCTEST Lab, Columbia, MD, USA

Test Report Serial No.: 0Y1205110681.ZNF

FCC ID: ZNFLG530G

APPLICANT: LG ELECTRONICS MOBILECOMM U.S.A., INC.

Scope of Test: Audio Band Magnetic Testing (T-Coil)

Application Type: Class II Permissive Change

FCC Rule Part(s): CFR § 20.19(b)

HAC Standard: ANSI C63.19-2007 §6.3(v), §7.3(v)

EUT Type: Portable Handset Model(s): LG530G, LG530g

Tx Frequencies Tested: 824.20 - 848.80 MHz (GSM 850)

1850.20 - 1909.80 MHz (GSM 1900) 826.40 - 846.60 MHz (WCDMA850) 1852.4 - 1907.6 MHz (WCDMA1900) Pre-Production Sample [S/N: HAC1]

Test Device Serial No.: Pre-Production Sample [S/N: HAC Class II Permissive Change(s): See FCC Change Document

Original Grant Date: 07/25/2012

C63.19-2007 HAC Category: T3 (SIGNAL TO NOISE CATEGORY)

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2007 and had been tested in accordance with the specified measurement procedures. Test results reported herein relate only to the item(s) tested. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. North American Bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

PCTEST certifies that no party to this application has been subject to a denial of Federal benefits that includes FCC benefits pursuant to Section 5301 of the Anti-Drug Abuse Act of 1988, 21 U.S.C. 862.







FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 1 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 1 01 30

TABLE OF CONTENTS

1.	INTRODUCTION	3
2.	TEST SITE LOCATION	4
3.	EUT DESCRIPTION	5
4.	ANSI C63.19-2007 PERFORMANCE CATEGORIES	6
5.	METHOD OF MEASUREMENT	8
6.	FCC 3G MEASUREMENTS	18
7.	TEST SUMMARY	19
8.	MEASUREMENT UNCERTAINTY	24
9.	EQUIPMENT LIST	25
10.	CALIBRATION CERTIFICATES	26
11.	CONCLUSION	33
12.	REFERENCES	34
13.	TEST SETUP PHOTOGRAPHS	36

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 2 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Page 2 01 36

1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. Approximately 500 million people worldwide and 30 million people in the United States suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- RF Magnetic-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid in-vitu

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 3 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage 3 01 36

2. TEST SITE LOCATION

I. Introduction

The map at the right shows the location of the PCTEST LABORATORY in Columbia, Maryland. It is in proximity to the FCC Laboratory, the Baltimore-Washington International (BWI) airport, the city of Baltimore and Washington, DC (See Figure 2-1).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility in New Concept Business Park, Guilford Industrial Park, Columbia, Maryland. The site address is 6660-B Dobbin Road, Columbia, MD 21045. The test site is one of the highest points in the Columbia area with an elevation of 390 feet above mean sea level. The site coordinates are 39° 11'15" N latitude and 76° 49' 38" W longitude. The facility is 1.5 miles north of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. There are no FM or TV transmitters within 15 miles of the site. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2003 on January 27, 2006 and Industry Canada.

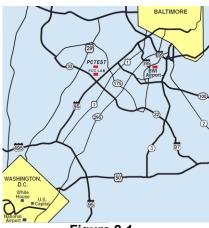


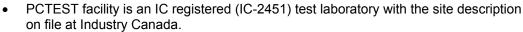
Figure 2-1
Map of the Greater Baltimore
and Metropolitan Washington,
D.C. Area

II. Test Facility / Accreditations:

Measurements were performed at an independent accredited PCTEST Engineering Lab located in Columbia, MD 21045, U.S.A.



- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing-Aid Compatibility (HAC), CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST facility is an FCC registered (PCTEST Reg. No. 90864) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (IC-2451).
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and all Industry Canada Standards (RSS).



- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS and CDMA, and EvDO mobile phones.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for Over-the-Air (OTA)
 Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO Data, CDMA 1xRTT Data.



FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 4 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Page 4 01 36

3. **EUT DESCRIPTION**



FCC ID: ZNFLG530G

Applicant: LG Electronics MobileComm U.S.A., Inc.

1000 Sylvan Avenue

Englewood Cliffs, NJ 07632

United States

Model(s): LG530G, LG530g

Serial Number: HAC1

Tx Frequencies Tested: 824.20 - 848.80 MHz (GSM 850)

1850.20 - 1909.80 MHz (GSM 1900) 826.40 - 846.60 MHz (WCDMA850) 1852.4 - 1907.6 MHz (WCDMA1900)

HW Version: 1.0

SW Version: LG530G-V09c

Maximum Tested Conducted Power 32.91 dBm (GSM 850), 29.66 dBm (GSM 1900),

(HAC): 22.85 dBm (WCDMA850), 22.34 dBm (WCDMA1900)
Antenna: Internal Antenna

HAC Test Configurations: GSM 850, 128, 190, 251, BT Off

GSM 1900, 512, 661, 810, BT Off

WCDMA850, 4132, 4183, 4233, BT Off

WCDMA1900, 9262, 9400, 9538, BT Off

EUT Type: Portable Handset

Air-Interface	Band (MHz)	Туре	C63.19-2007 tested	Simultaneous Transmissions Scenarios in voice modes (Not to be tested)	Reduced power 20.19 (c)(1)	VOIP
	850	Voice	Yes	Yes: BT	NA	N/A
	1900	Voice	Yes	Yes: BT	NA	N/A
GSM	GPRS/ EDGE Rx only	Data	NA	NA	NA	Yes
WCDMA	835	Voice	Yes	Yes: BT	NA	N/A
VVCDIVIA	1900	Voice	res	fes. bi	IVA	N/A
BT	2450	Data	NA	Yes: GSM or WCDMA	NA	NA

NOTE: HAC Rating was not based on concurrent voice and data modes. Standalone mode was found to represent worst case rating for both M and T rating.

Table 3: ZNFLG530G Air Interfaces

FCC ID: ZNFLG530G	PCTEST*	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 5 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 5 01 36

4. ANSI C63.19-2007 PERFORMANCE CATEGORIES

I. MAGNETIC COUPLING

Axial and Radial Field Intensity

All orientations of the magnetic field, in the axial, horizontal and vertical position along the measurement plane shall be \geq -18 dB(A/m) at 1 kHz in a 1/3 octave band filter per 7.3.1.

Frequency Response

The frequency response of the axial component of the magnetic field shall follow the response curve specified in EIA RS-504-1983, over the frequency range 300 Hz – 3000 Hz per 7.3.2.

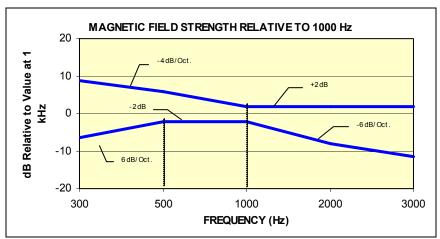


Figure 4-1
Magnetic field frequency response for Wireless Devices with an axial field ≤ -15 dB (A/m) at 1 kHz

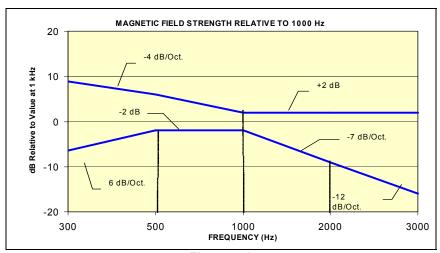


Figure 4-2
Magnetic Field frequency response for wireless devices with an axial field that exceeds
-15 dB(A/m) at 1 kHz

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 6 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage o or so

Signal Quality

The table below provides the signal quality requirement for the intended audio magnetic signal from a wireless device. Only the RF immunity of the hearing aid is measured in T-coil mode. It is assumed that a hearing aid can have no immunity to an interference signal in the audio band, which is the intended reception band for this mode. The only criterion that can be measured is the RF immunity in T-coil mode. This is measured using the same procedure as the audio coupling mode at the same levels.

The signal quality of the axial and radial components of the magnetic field was used to determine the T-coil mode category.

Category	Telephone RF Parameters		
	Wireless Device Signal Quality (Signal + Noise-to-noise ratio in dB)		
T1	0 to 10 dB		
T2	10 to 20 dB		
Т3	20 to 30 dB		
T4	> 30 dB		
Table 4-1 Magnetic Coupling Parameters			

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 7 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage / 01 36

5. METHOD OF MEASUREMENT

I. Test Setup

The equipment was connected as shown in an acoustic/RF hemi-anechoic chamber:

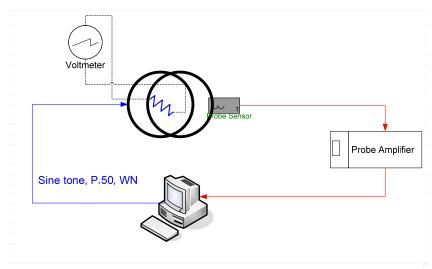


Figure 5-1 Validation Setup with Helmholtz Coil

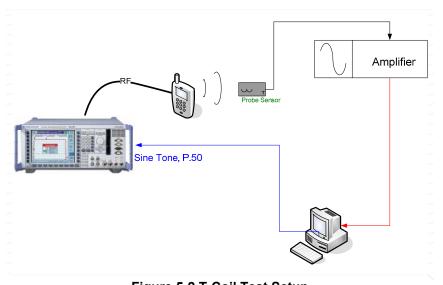


Figure 5-2 T-Coil Test Setup

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 8 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage o oi so

II. Scanning Mechanism

Manufacturer: TEM

Accuracy: ± 0.83 cm/meter

Minimum Step Size: 0.1 mm

Maximum speed 6.1 cm/sec
Line Voltage: 115 VAC
Line Frequency: 60 Hz

Material Composite: Delrin (Acetal)

Data Control: Parallel Port

Dynamic Range (X-Y-Z): 45 x 31.75 x 47 cm

Dimensions: 36" x 25" x 38" Operating Area: 36" x 49" x 55"

Reflections: < -20 dB (in anechoic chamber)

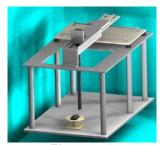


Figure 5-3 RF Near-Field Scanner

III. ITU-T P.50 Artificial Voice

Manufacturer: ITU-T

Active Frequency 100 Hz – 8 kHz

Range:

Stimulus Type: Male and Female, no spaces

Single Sample Duration: 20.96 seconds

Activity Level: 100%

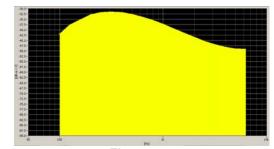


Figure 5-4
Spectral Characteristic of full P.50

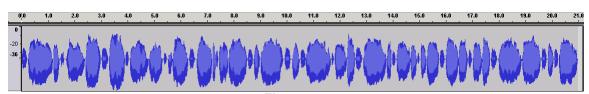


Figure 5-5
Temporal Characteristic of full P.50

FCC ID: ZNFLG530G	PCTEST*	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 9 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 9 01 36

ABM1 Measurement Block Diagram:

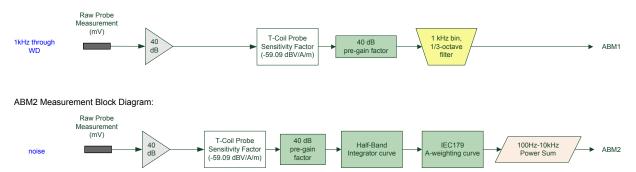


Figure 5-6 Magnetic Measurement Processing Steps

IV. Test Procedure

- 1. Ambient Noise Check per C63.19 §6.2.1
 - a. Ambient interference was monitored using a Real-Time Analyzer between 100-10,000 Hz with 1/3 octave filtering.
 - b. "A-weighting" and Half-Band Integration was applied to the measurements.
 - c. Since this measurement was measured in the same method as ABM2 measurements, this level was verified to be less than 10 dB below the lowest measurement signal (which is the highest ABM2 measurement for a T4 WD). Therefore the maximum noise level for a T4 WD with an ABM1 = -18 dBA/m is:

$$-18 - 30 - 10 = -58 \text{ dBA/m}$$

- 2. Measurement System Validation (See Figure 5-1)
 - The measurement system including the probe, pre-amplifier and acquisition system were validated as an entire system to ensure the reliability of test measurements.
 - b. ABM1 Validation

The magnetic field at the center of the Helmholtz coil is given by the equation (per C63.19 Annex D.9.1):

$$H_c = \frac{NI}{r\sqrt{1.25^3}} = \frac{N(\frac{V}{R})}{r\sqrt{1.25^3}}$$

Where H_c = magnetic field strength in amperes per meter N = number of turns per coil

For the Helmholtz Coil, N=20; r=0.08m; R=10.193 Ω and using V=57mV:

$$H_c = \frac{20 \cdot (\frac{0.057}{10.193})}{0.08 \cdot \sqrt{1.25^3}} = 1.0003 A/m$$

Therefore a pure tone of 1kHz was applied into the coils such that 57 mV was observed across the 10 Ω resistor. The voltmeter used for measurement was verified to be capable of measurements in the audio band range. This theoretically generates an expected field of 1 A/m in the center of the Helmholtz coil which was used to validate the probe

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 10 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage 10 01 36

measurement at 1 A/m. This was verified to be within \pm 0.5 dB of the 1 A/m value (see Page 20).

c. Frequency Response Validation

The frequency response through the Helmholtz Coil was verified to be within 0.5 dB relative to 1 kHz, between 300 – 3000 Hz using the ITU-P.50 artificial speech signal as shown below:

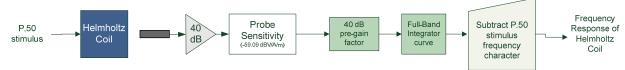


Figure 5-7 Frequency Response Validation

d. ABM2 Measurement Validation

WD noise measurements are filtered with A-weighting and Half-Band Integration over a frequency range of 100Hz – 10kHz to process ABM2 measurements. Below is the verification of the system processing A-weighting and Half-Band integration between system input to output within 0.5 dB of the theoretical result:

Table 5-1
ABM2 Frequency Response Validation

	HBI, A -	HBI, A -	
f (Hz)	Measured	Theoretical	dB Var.
	(dB re 1kHz)	(dB re 1kHz)	
100	-16.180	-16.170	-0.010
125	-13.257	-13.250	-0.007
160	-10.347	-10.340	-0.007
200	-8.017	-8.010	-0.007
250	-5.925	-5.920	-0.005
315	-4.045	-4.040	-0.005
400	-2.405	-2.400	-0.005
500	-1.212	-1.210	-0.002
630	-0.349	-0.350	0.001
800	0.071	0.070	0.001
1000	0.000	0.000	0.000
1250	-0.503	-0.500	-0.003
1600	-1.513	-1.510	-0.003
2000	-2.778	-2.780	0.002
2500	-4.316	-4.320	0.004
3150	-6.166	-6.170	0.004
4000	-8.322	-8.330	0.008
5000	-10.573	-10.590	0.017
6300	-13.178	-13.200	0.022
8000	-16.241	-16.270	0.029
10000	-19.495	-19.520	0.025

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	€ LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 11 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Page 11 01 36



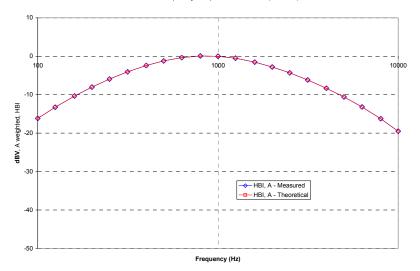
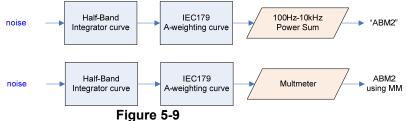


Figure 5-8
ABM2 Frequency Response Validation

The ABM2 result is a power sum from 100 Hz to 10 kHz with half-band integration and A-weighting. To verify the power sum measurement, a power sum over the full band was measured and verified to track with the source level (See Figure 5-9). Therefore the setup in this step was used to verify the power sum post-processing for ABM2 measurements. See below block diagram:



ABM2 Validation Block Diagram

The power summed output results for a known input were compared to the multi-meter results to verify any deviation in the post-processing implemented with the power-sum.

Table 5-2
ABM2 Power Sum Validation

WN Input (dBV)	Power Sum (dBV)	Multimeter-Full (dBV)	Dev (dB)
-60	-60.36	-60.2	0.16
-50	-50.19	-50.13	0.06
-40	-40.14	-40.03	0.11
-30	-30.13	-30.01	0.12
-20	-20.12	-20	0.12
-10	-10.14	-10	0.14

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 12 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Page 12 01 36

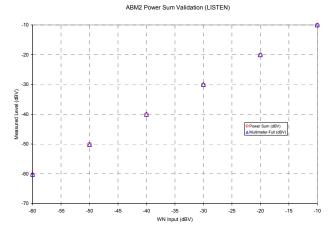


Figure 5-10
ABM2 Power Sum Validation

- 3. Measurement Test Setup
 - a. Fine scan above the WD (TEM)
 - i. A multitone signal was applied to the handset such that the phone acoustic output was stable within 1dB over the probe settling time and with the acoustic output level at the C63.19 specified levels (below). The measurement step size was in 2 mm increments at a distance of 10 mm between the surface of the wireless device as shown below:

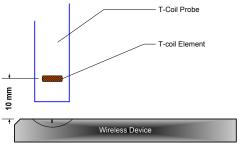


Figure 5-11
Measurement Distance

- ii. After scanning, the planar field maximum point was determined. The position of the probe was moved to this location to setup the test using the sound check system.
- iii. These steps were repeated for the other T-coil orientations (of axial, radial transverse, or radial longitudinal) per Figure 5-16 after a T-coil orientation was fully measured with the sound check system.
- b. Speech Signal Setup to Base Station Simulator
 - i. C63.19 Table 6-1 states audio reference input levels for various technologies:

Standard	Technology	Input Level (dBm0)
TIA/EIA/IS-2000	CDMA	-18
J-STD-007	GSM (217)	-16
T1/T1P1/3GPP	UMTS (WCDMA)	-16
iDEN TM	TDMA (22 and 11 Hz)	-18

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	① LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 13 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Page 13 01 36

The CMU200 audio levels were determined using base station simulator manufacturer calibration procedures resulting in the below corresponding voltages relative to handset test point level (in dBm0):

Table 5-3
CMU200 Voltage Input Levels for Audio

amouto romago mpan utrono non rimano					
dBm0 Ref.	Voltage		Notes		
3.14 dBm0	990.5 mV	-0.08 dBV	From GSM "DECODER CAL". (What is needed through Encoder for FS)		
-16 dBm0	109.4 mV	-19.2 dBV	For Speechcod/Handset Low		
dBm0 Ref.	Volt	tage	Notes		
dBm0 Ref. 3.14 dBm0	Volt	age 0.58 dBV	Notes From UMTS "DECODER CAL". (What is needed through Encoder for FS)		

- c. Real-Time Analyzer (RTA)
 - The Real-Time Analyzer was configured to analyze measurements using 1/3 Octave band weighted filtering.
- d. WD Radio Configuration Selection
 - i. The device was chosen to be tested in the worst-case ABM2 condition under EFR (GSM); AMR 12.2 kbps (WCDMA); (see below):

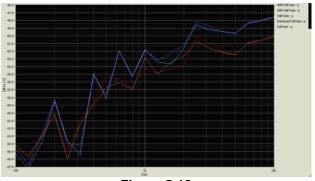


Figure 5-12 Vocoder Analysis for ABM Noise

- 4. Signal Quality Data Analysis
 - a. Narrow-band Magnetic Intensity
 - i. The standard specifies a 1 kHz 1/3 octave band minimum field intensity for a sine tone. The ABM1 measurements were evaluated at 1kHz with 1/3 octave band filtering over an averaged period of 10 seconds.
 - b. Frequency Response
 - i. The appropriate frequency response curve was measured to curves in Figure 4-1 or Figure 4-2 between 300 3000 Hz using digital linear averaging (limit lines chosen according to measurement found in step 4a.) A linear average over 3x the length of the artificial voice signal (3x sampling) was performed. A 10 second delay was configured in the measurement process of the stimulus to ensure handset vocoder latency effects and echo cancellation devices (if any) were appropriately stabilized during measurements.

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 14 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 14 01 36

ii. The appropriate post-processing was applied according to the system processing chain illustrated in Figure 5-13. All R10 frequencies were plotted with respect to 0dB at 1 kHz value and aligned with respect to the EIA-504 mask.



Figure 5-13 Frequency Response Block Diagram

iii. The margin is represented by the closest measured data point on the curve to the EIA-504 limit lines, in dB.

c. Signal Quality Index

- i. Ensuring the WD was at maximum RF power, maximum volume, backlight on, display on, maximum contrast setting, keypad lights on (when possible) with no audio signal through the vocoder, the WD was measured over at least 100 Hz 10,000 Hz, maximized over 5 seconds with a 50ms sample time for the ABM2 measurement (5 second time period is used in noise measurements under standards such as IEEE 269, etc.)
- ii. After applying half-band integration and A-weighting to the result, a power sum was applied over each 1/3 octave bandwidth frequency for an ABM2 value
- This result was subtracted from the ABM1 result in step a, to obtain the Signal Quality.

V. Test Setup

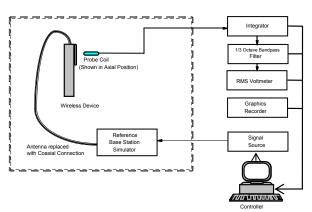


Figure 5-14
Audio Magnetic Field Test Setup

VI. Deviation from C63.19 Test Procedure

Non-conducted RF connection.

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 15 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage 15 01 36

VII. Wireless Device Channels and Frequencies

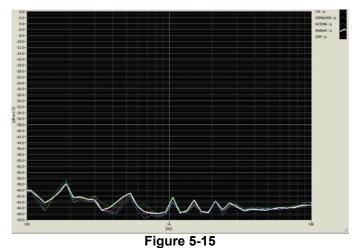
The frequencies listed in the table below are those that lie in the center of the bands used for cellular telephony. Low, middle and high channels were tested in each band for FCC compliance evaluation to ensure the maximum emission is captured across the entire band.

To facilitate setting of a base station simulator for ABM measurements, specific band plan channel numbers are listed that may be used in lieu of the band center frequencies.

Table 5-4
Center Channels and Frequencies

Test frequencies & associated channels				
Channel	Frequency (MHz)			
Cellular 850				
4183(WCDMA)	836.60			
190 (GSM)	836.60			
AWS 1700 / PCS 19	900			
661 (GSM)	1880			
1412 (WCDMA)	1730.40			
9400 (WCDMA)	1880			

VIII. RF Emission Effect on T-coil Measurements



High power RF Emissions Effect with HAC Dipole on the T-coil Probe System 10mm between dipole maximum and magnetic probe

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 16 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage 10 01 36

IX. Test Flow

The flow diagram below was followed (From C63.19):

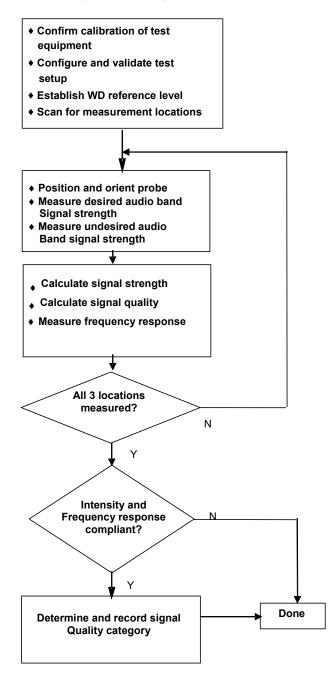


Figure 5-16 C63.19 T-Coil Signal Test Process

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 17 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 17 01 36

6. FCC 3G MEASUREMENTS

AMR at 12.2kbps, 13.6kbps SRB was used for the testing as the worst-case configuration for the handset. See below plot for ABM noise comparison between vocoder rates:

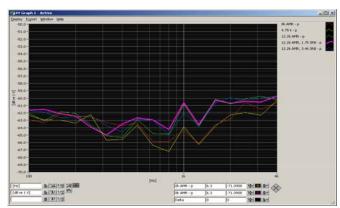


Figure 6-1
WCDMA Audio Band Magnetic Noise

I. ABM Measurements

Table 6-1 FCC 3G ABM Measurements for LG530G, LG530g

ABM2 Pre-Test (dBA/m), A, HBI

AMR 12.2kbps	AMR 7.95kbps	AMR 4.75kbps	Orientation	Channel
-47.66	-48.44	-48.17	RadialV	9538

ABM1 Pre-Test (dBA/m)

AMR 12.2kbps	AMR 7.95kbps	AMR 4.75kbps	Orientation	Channel
-3.720	-3.710	-3.860	RadialV	9538

- Mute on; Backlight on; Max Volume, Max Contrast
- GSM850: PCL=5, GSM1900: PCL=0; WCDMA: TPC="All 1s";



Figure 6-2
Audio Band Magnetic Curve Measurement Block Diagram

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 18 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage 10 01 36

7. TEST SUMMARY

I. T-Coil Test Summary

Table 7-1
Table of Results for GSM

C63.19 Sec.	Mode	Band	Test Description	Minimum Limit*	Measured	Verdict
				dBA/m	dBA/m	PASS/FAIL
7.3.1.1			Intensity, Axial	-18	4.9	PASS
7.3.1.2			Intensity, RadialH	-18	-3.9	PASS
7.3.1.2		Cellular	Intensity, Radial V	-18	-3.5	PASS
7.3.3	GSM		Signal-to-Noise/Noise, Axial	20	35.7	PASS
7.3.3			Signal-to-Noise/Noise, Radial H	20	32.2	PASS
7.3.3			Signal-to-Noise/Noise, Radial V	20	29.5	PASS
7.3.2			Frequency Response, Axial	0	1.7	PASS
7.3.1.1			Intensity, Axial	-18	4.8	PASS
7.3.1.2			Intensity, RadialH	-18	-3.8	PASS
7.3.1.2			Intensity, Radial V	-18	-3.5	PASS
7.3.3	GSM	PCS	Signal-to-Noise/Noise, Axial	20	37.3	PASS
7.3.3			Signal-to-Noise/Noise, RadialH	20	33.4	PASS
7.3.3			Signal-to-Noise/Noise, Radial V	20	32.3	PASS
7.3.2			Frequency Response, Axial	0	1.7	PASS

Table 7-2
Table of Results for WCDMA

C63.19 Sec.	Mode	Band	Test Description	Minimum Limit*	Measured	Verdict
				dBA/m	dBA/m	PASS/FAIL
7.3.1.1			Intensity, Axial	-18	4.7	PASS
7.3.1.2			Intensity, RadialH	-18	-4.0	PASS
7.3.1.2		Cellular	Intensity, RadialV	-18	-3.6	PASS
7.3.3	WCDMA		Signal-to-Noise/Noise, Axial	20	49.7	PASS
7.3.3			Signal-to-Noise/Noise, Radial H	20	45.4	PASS
7.3.3			Signal-to-Noise/Noise, Radial V	20	44.6	PASS
7.3.2			Frequency Response, Axial	0	2.0	PASS
7.3.1.1			Intensity, Axial	-18	4.7	PASS
7.3.1.2			Intensity, RadialH	-18	-4.0	PASS
7.3.1.2			Intensity, RadialV	-18	-3.7	PASS
7.3.3	WCDMA	PCS	Signal-to-Noise/Noise, Axial	20	49.9	PASS
7.3.3			Signal-to-Noise/Noise, RadialH	20	45.4	PASS
7.3.3			Signal-to-Noise/Noise, Radial V	20	44.3	PASS
7.3.2			Frequency Response, Axial	0	1.9	PASS

Note: The above summary table represents the worst-case numerical values according to configurations in Tables 7-4 and 7-5.

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 19 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 19 01 36

Table 7-3
Consolidated Tabled Results

	Volume Setting		Cellular			PCS	
		Axial	RadialH	RadialV	Axial	RadialH	RadialV
Freq. Response Margin		PASS	PASS	PASS	PASS	PASS	PASS
Magnetic Intensity Verdict	Maximum	PASS	PASS	PASS	PASS	PASS	PASS
FCC SNR Verdict		PASS	PASS	PASS	PASS	PASS	PASS

Note: Result shown is for T-coil category only.

II. Raw Handset Data

Table 7-4
GSM Raw Data Results

COM Naw Data Nesults										
	Volume				C	ellular Baı	nd			
			Axial			RadialH			RadialV	
		128	190	251	128	190	251	128	190	251
ABM1, dBA/m		4.90	5.11	4.89	-3.93	-3.72	-3.93	-3.54	-3.12	-3.42
ABM2, dBA/m		-30.83	-32.82	-33.03	-36.10	-37.80	-37.95	-33.02	-35.33	-35.76
Ambient Noise, dBA/m		-62.24	-62.24	-62.24	-61.81	-61.81	-61.81	-61.64	-61.64	-61.64
Freq. Response Margin (dB)	Maximum	1.74	1.82	1.76	1.73	1.68	1.78	1.73	1.74	1.77
S+N/N (dB)		35.73	37.93	37.92	32.17	34.08	34.02	29.48	32.21	32.34
S+N/N per orientation (dB)			35.73			32.17			29.48	
	Volume	PCS Band								
			Axial			RadialH			RadialV	
		512	661	810	512	661	810	512	661	810
ABM1, dBA/m		4.87	4.79	4.93	-3.78	-3.67	-3.45	-3.48	-3.51	-3.49
ABM2, dBA/m		-34.16	-33.91	-32.33	-38.46	-37.99	-36.81	-37.33	-37.05	-35.76
Ambient Noise, dBA/m		-62.24	-62.24	-62.24	-61.81	-61.81	-61.81	-61.64	-61.64	-61.64
Freq. Response Margin (dB)	Maximum	1.78	1.79	1.74	1.78	1.77	1.62	1.73	1.77	1.72
S+N/N (dB)		39.03	38.70	37.26	34.68	34.32	33.36	33.85	33.54	32.27
S+N/N per orientation (dB)			37.26			33.36			32.27	
T-coil Coordinates (cm)	[x,y] from bottom left		2.3,2.4			2.4,3.4			3.4,2.4	

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 20 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Page 20 01 36

Table 7-5
WCDMA Raw Data Results

	Volume				C	ellular Baı	nd			
			Axial			RadialH			RadialV	
		4132	4183	4233	4132	4183	4233	4132	4183	4233
ABM1, dBA/m		4.80	4.72	4.79	-4.02	-3.93	-3.87	-3.55	-3.61	-3.63
ABM2, dBA/m		-45.25	-45.01	-45.28	-49.43	-49.47	-49.26	-48.29	-48.17	-48.31
Ambient Noise, dBA/m		-62.24	-62.24	-62.24	-61.81	-61.81	-61.81	-61.64	-61.64	-61.64
Freq. Response Margin (dB)	Maximum	2.00	2.00	1.96	2.00	1.99	2.00	2.00	2.00	2.00
S+N/N (dB)		50.05	49.73	50.07	45.41	45.54	45.39	44.74	44.56	44.68
S+N/N per orientation (dB)			49.73			45.39			44.56	
	Volume	PCS Band								
			Axial			RadialH			RadialV	
		9262	9400	9538	9262	9400	9538	9262	9400	9538
ABM1, dBA/m		4.74	4.68	4.72	-3.97	-3.84	-3.64	-3.68	-3.67	-3.71
ABM2, dBA/m		-45.26	-45.21	-45.21	-49.33	-49.45	-49.34	-48.61	-48.70	-48.01
Ambient Noise, dBA/m		-62.24	-62.24	-62.24	-61.81	-61.81	-61.81	-61.64	-61.64	-61.64
Freq. Response Margin (dB)	Maximum	1.87	2.00	1.93	1.98	1.95	2.00	2.00	2.00	2.00
S+N/N (dB)		50.00	49.89	49.93	45.36	45.61	45.70	44.93	45.03	44.30
S+N/N per orientation (dB)			49.89			45.36			44.30	
T-coil Coordinates (cm)	[x,y] from bottom left		2.3,2.4			2.4,3.4			3.4,2.4	

Notes:

- 1. Power Configuration: GSM850: PCL=5, GSM1900: PCL=0; WCDMA: TPC="All 1s";
- 2. Phone Condition: Mute on; Backlight on; Max Volume, Max Contrast
- 3. Vocoder Configuration: EFR (GSM); AMR 12.2 kbps (WCDMA);

III. Frequency Response Graph

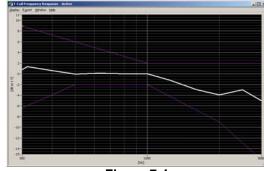
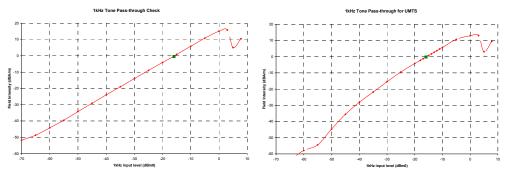


Figure 7-1
Axial Frequency Response

Note: User T-coil Mode (Menu->Settings->Call->Accessibility->Hearing aid) was set to ON for Frequency Response compliance. This frequency response represents the worst-case ABM2 test configuration according to Tables 7-4 and 7-5.

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	① LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 21 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Page 21 01 36

IV. 1 kHz Vocoder Application Check



This model was verified to be within the linear region for ABM1 measurements at -16 dBm0. This measurement was taken in the axial configuration above the maximum location, cellular band, mid channel.

V. Undesirable Audio Magnetic Band Plot (ABM2)

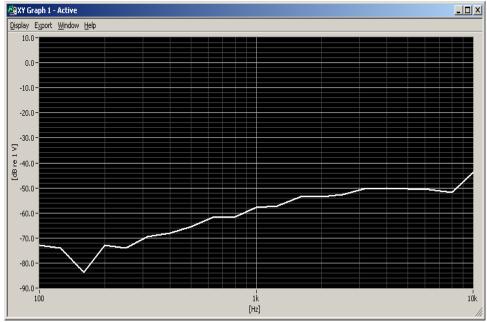


Figure 7-2
Worst-case ABM2 Plot for WD

Note: This plot represents the data from the location/configuration resulting in the highest ABM2 result shown in Tables 7-4 and 7-5.

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 22 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 22 01 36

VI. T-Coil Validation Test Results

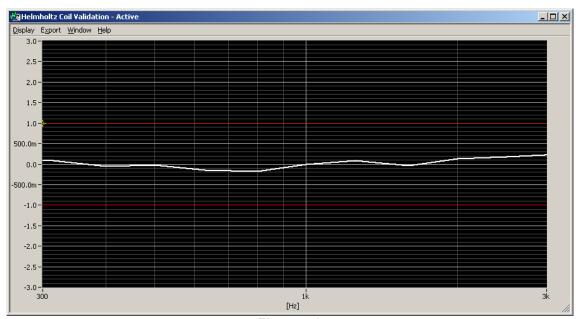


Figure 7-3
Helmholtz Coil Validation for Frequency Response

Table 7-6
Helmholtz Coil Validation Table of Results

ltem	Target	Result	Verdict
Signal Validation			
Frequency Response, from limits	0 ± 0.5 dB	0.23	PASS
Magnetic Intensity, -10 dBA/m	0 ± 0.5 dB	0.009	PASS
Noise Validation			
Axial Environmental Noise	< - 58 dBA/m	-62.24	PASS
RadialH Environmental Noise	< - 58 dBA/m	-61.81	PASS
RadialV Environmental Noise	< - 58 dBA/m	-61.64	PASS

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 23 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 23 01 36

8. MEASUREMENT UNCERTAINTY

Table 8-1
Uncertainty Estimation Table

Contribution	Data +/- %	Data +/- dB	Data Type	Probability distribution	Divisor	Standard uncertainty	Standard Uncertainty (dB)
ABM Noise	7.0%	0.29	Std. Dev.	Normal k=1	1.00	7.0%	
RF Reflections	4.7%	0.20	Specification	Rectangular	1.73	2.7%	
Reference Signal Level	12.2%	0.50	Specification	Rectangular	1.73	7.0%	
Positioning Accuracy	10.0%	0.41	Uncertainty	Rectangular	1.73	5.8%	
Probe Coil Sensitivity	12.2%	0.50	Specification	Rectangular	1.73	7.0%	
Probe Linearity	2.4%	0.10	Std. Dev.	Normal k=1	1.00	2.4%	
Cable Loss	2.8%	0.12	Specification	Rectangular	1.73	1.6%	
Frequency Analyzer	5.0%	0.21	Specification	Rectangular	1.73	2.9%	
System Repeatability	5.0%	0.21	Std. Dev.	Normal k=1	1.00	5.0%	
WD Repeatability	9.0%	0.37	Std. Dev.	Normal k=1	1.00	9.0%	
Positioner Accuracy	1.0%	0.04	Specification	Rectangular	1.73	0.6%	
Combined standard uncertainty, uc (k=1)						17.7%	0.71
Expanded uncertainty (k=2), 95% confidence level						35.3%	1.31

Notes:

- 1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297.
- All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid compatibility tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

FCC ID: ZNFLG530G	PCTEST*	HAC (T-COIL) TEST REPORT	① LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 24 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Page 24 01 36

9. EQUIPMENT LIST

Table 9-1 Equipment List

Equipmont List							
Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number	
Agilent	E5515C	Wireless Communications Test Set	2/14/2012	Annual	2/14/2013	GB43304447	
Agilent	E4407B	ESA Spectrum Analyzer	4/3/2012	Annual	4/3/2013	US39210313	
Agilent	E5515C	Wireless Communications Tester	4/4/2012	Annual	4/4/2013	US41140256	
Control Company	36934-158	Wall-Mounted Thermometer	1/4/2012	Biennial	1/4/2014	122014497	
Control Company	36934-158	Wall-Mounted Thermometer	1/4/2012	Biennial	1/4/2014	122014488	
Gigatronics	80701A	(0.05-18GHz) Power Sensor	10/12/2011	Annual	10/12/2012	1833460	
Gigatronics	8651A	Universal Power Meter	10/12/2011	Annual	10/12/2012	8650319	
Listen	Soundconnect	Microphone Power Supply	7/13/2011	Annual	7/13/2012	PS1435	
Listen	SoundCheck	Acoustic Analyzer System	8/23/2011	Annual	8/23/2012	40603797	
Narda	4014C-6	4 - 8 GHz SMA 6 dB Directional Coupler	NA	CBT*	NA	N/A	
NI	4474	Data Acquisition Card	N/A		NA	N/A	
Rohde & Schwarz	CMW500	LTE Radio Communication Tester	10/7/2011	Annual	10/7/2012	103962	
Seekonk	NC-100	Torque Wrench (8" lb)	11/29/2011	Triennial	11/29/2014	21053	
Seekonk	NC-100	Torque Wrench (8" lb)	3/5/2012	Triennial	3/5/2015	N/A	
Seekonk	NC-100	Torque Wrench (8" lb)	3/5/2012	Triennial	3/5/2015	N/A	
TEM	Axial T-coil Probe	Axial T-Coil Probe	6/15/2011	Annual	6/15/2012	TEM-1105	
TEM	Radial T-Coil Probe	Radial T-Coil Probe	6/15/2011	Annual	6/15/2012	TEM-1121	
TEM	Radial T-Coil Probe	Radial T-Coil Probe	1/20/2012	Annual	1/20/2013	TEM-1130	
TEM	Axial T-Coil Probe	Axial T-Coil Probe	1/20/2012	Annual	1/20/2013	TEM-1124	
TEM	Axial T-Coil Probe	Axial T-Coil Probe	3/14/2012	Annual	3/14/2013	TEM-1139	
TEM	Radial T-Coil Probe	Radial T-Coil Probe	3/14/2012	Annual	3/14/2013	TEM-1133	
TEM	C63.19	Helmholtz Coil	11/11/2011	Biennial	11/11/2013	925	
TEM		HAC System Controller with Software	NA		NA	N/A	
TEM		HAC Positioner	NA		NA	N/A	

Note: CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.

FCC ID: ZNFLG530G	PCTEST*	HAC (T-COIL) TEST REPORT	① LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 25 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 25 01 36

10. CALIBRATION CERTIFICATES

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 26 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 20 01 36

West Caldwell Calibration Laboratories Inc.

Certificate of Calibration

for

Axial T Coil Probe

Manufactured by:

TEM CONSULTING

Model No:

Axial T Coil Probe

Serial No: Calibration Recall No: TEM-1124 21559

Submitted By:

Customer:

STEVE LIU

Company: Address: PCTEST ENGINEERING LAB

6660-B DOBBIN ROAD

COLUMBIA

MD 21045

The subject instrument was calibrated to the indicated specification using standards traceable to the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the submitter

West Caldwell Calibration Laboratories Procedure No.

Axial T Coi TEM

Upon receipt for Calibration, the instrument was found to be:

Within

(\mathbf{X}) see attached Report of Calibration.

the tolerance of the indicated specification.

West Caldwell Calibration Laboratories' calibration control system meets the requirements, ISO 10012-1 MIL-STD-45662A, ANSI/NCSL Z540-1, IEC Guide 25, ISO 9001:2008 and ISO 17025.

Note: With this Certificate, Report of Calibration is included.

Approved by:

Calibration Date:

20-Jan-12

Ы.

Certificate No:

QA Doc. #1051 Rev. 2.0 10/1/01

21559 - 1

Certificate Page 1 of 1

Felix Christopher Quality Manager

West Caldwell
Calibration

uncompromised calibration Laboratories, Inc. 1575 State Route 96, Victor, NY 14564, U.S.A.

Registered Company Calbration Traceable To N. I. S. T.

Phone: (585) 586-3900 Fax.: (585) 586-4327

ACCREDITED 153141 (85) 586-4327

FCC ID: ZNFLG530G	PCTEST*	HAC (T-COIL) TEST REPORT	(L)	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 27 of 38
0V1205110681 7NE	5/20/2012	Portable Handset		Faye 27 01 30





1575 State Route 96, Victor NY 14564

REPORT OF CALIBRATION

1533.01

TEM Consulting LP Axial T Coil Probe

Model No.: Axial T Coil Probe

Serial No.: TEM-1124

Company: Pctest Engineering Lab.

I. D. No: 80578

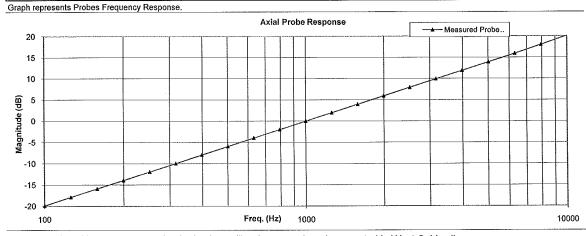
alibration results:			Before data:	After data	:
Probe Sensitivity measured wit	h Helmhol	tz Coil			
Helmholtz Coll;			Before & afte	er data same	:X
the number of turns on each coil;	10	No.			
the radius of each coil, in meters;	0.204	m	Laboratory Enviror	iment:	
the current in the coils, in amperes.;	0.08	Α	Ambient Temperature:	22.1	°C
Helmholtz Coll Constant;	6.98	A/m/V	Ambient Humidity:	30.8	% RH
Helmholtz Coil magnetic field;	5.90	A/m	Ambient Pressure:	100.1	kPa
			Calibration Date:	20-Jan-12	1:01 PM
Probe Sensitivity at	1000	Hz.	Re-calibration Due:	20-Jan-13	
was	-60.16	dBV/A/m	Report Number:	21559	-1
	0.981	mV/A/m	Control Number:	21559	
Probe resistance	904	Ohms			

The above listed instrument meets or exceeds the tested manufacturer's specifications.

This Calibration is traceable through NIST test numbers:

,205342

The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2.



The above listed instrument was checked using calibration procedure documented in West Caldwell

Calibration Laboratories Inc. procedure :

Rev. 5.0 Sept. 10, 2010 Doc. # 1038 HCATEMC

Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures

intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2008, ISO 17,025

Cal. Date: 20-Jan-2012

1:01 PM

Measurements performed by:

Calibrated on WCCL system type 9700

Felix Christopher

Rev. 5.0 Sept. 10, 2010 Doc. # 1038 HCATEMC

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Page 1 of 2

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 28 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 26 01 36

HCATEMC_TEM-1124_Jan-20-2012

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564 Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Axial T Coil Probe

for Model No.: Axial T Coil Probe

Serial No.: TEM-1124

Company: Pctest Engineering Lab.

Function	tion Tolerance			Measured values			
			Before	Out	Remarks		
Probe Sensitivity at	1000 Hz.	dBV/A/m	-60.16				
		dB					
Probe Level Linearity		6	6.03				
	Ref. (0 dB)	0	0.00				
		-6	-6.02				
		-12	-12.03				
		Hz					
3.0 Probe Frequency Response		100			1		
		126	1				
		158					
		200			ļ		
		251	-11.9				
		316	-10.0				
		398	-8.0				
		501	-6.0				
		631	-4.0				
		794	-2.0				
	Ref. (0 dB)	1000	0.0				
		1259	2.0				
		1585	4.0				
		1995	6.0		1		
		2512	7.9		1		
		3162	9.9		. [
		3981	11.9				
		5012	13.9		[
		6310	15.9				
		7943	18.0				
		10000	20.2				
	Probe Sensitivity at Probe Level Linearity	Probe Sensitivity at 1000 Hz. Probe Level Linearity Ref. (0 dB) Probe Frequency Response	Probe Sensitivity at 1000 Hz. dBV/A/m Probe Level Linearity Ref. (0 dB) Ref. (0 dB) O -6 -12 Probe Frequency Response Hz Probe Frequency Response 100 126 158 200 251 316 398 501 631 794 Ref. (0 dB) 1000 1259 1585 1995 2512 3162 3981 5012 6310 7943	Probe Sensitivity at 1000 Hz. dBV/A/m -60.16 Probe Level Linearity 6 6 6.03 Ref. (0 dB) 0 0.00 -6 -6.02 -12 -12.03 Probe Frequency Response 100 -19.9 126 -17.9 158 -15.9 200 -13.9 251 -11.9 316 -10.0 398 -8.0 501 -6.0 631 -4.0 794 -2.0 Ref. (0 dB) 1000 0.0 1259 2.0 1585 4.0 1995 6.0 2512 7.9 3162 9.9 3981 11.9 5012 13.9 6310 15.9 7943 18.0	Probe Sensitivity at 1000 Hz. dBV/A/m -60.16 Probe Level Linearity Ref. (0 dB) R		

Instruments used for calibrati	on:		Date of Cal.	Traceability No.	Due Date
HP	34401A	S/N US360641	17-Oct-2011	,205342	16-Oct-2012
HР	34401A	S/N US361024	17-Oct-2011	,205342	16-Oct-2012
HP	33120A	S/N S3604371	17-Oct-2011	,205342	16-Oct-2012
B&K	2133	S/N 1492410	4-Nov-2011	681/280411-11	4-Nov-2012

Cal. Date: 20-Jan-2012

1:01 PM

Tested by: Felix Christopher

Calibrated on WCCL system type 9700

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Rev. 5.0 Sept. 10, 2010 Doc. # 1038 HCATEMC

Page 2 of 2

FCC ID: ZNFLG530G	PCTEST*	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 29 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 29 01 36

West Caldwell Calibration Laboratories Inc. **Certificate of Calibration** Radial T Coil Probe TEM CONSULTING Manufactured by: Model No: Radial T Coil Probe TEM-1130 Serial No: Calibration Recall No: 21559 Submitted By: STEVE LIU Customer: PCTEST ENGINEERING LAB Company: 6660-B DOBBIN ROAD Address: COLUMBIA MD 21045 The subject instrument was calibrated to the indicated specification using standards traceable to the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the Radial T C TEM West Caldwell Calibration Laboratories Procedure No. Upon receipt for Calibration, the instrument was found to be: (X)see attached Report of Calibration. the tolerance of the indicated specification. West Caldwell Calibration Laboratories' calibration control system meets the requirements, ISO 10012-1 MIL-STD-45662A, ANSI/NCSL Z540-1, IEC Guide 25, ISO 9001:2008 and ISO 17025. Note: With this Certificate, Report of Calibration is included. Approved by: Calibration Date: 20-Jan-12 Felix Christopher Certificate No: 21559 - 2 Quality Manager OA Doc. #1051 Rev. 2.0 10/1/01 Certificate Page 1 of 1 West Caldwell ISO 9001:2008 Registered Company Calibration uncompromised calibration Laboratories. Inc. 1575 State Route 96, Victor, NY 14564, U.S.A. Phone: (585) 586-3900 Fax.: (585) 586-4327

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 30 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage 30 01 36





1575 State Route 96, Victor NY 14564

REPORT OF CALIBRATION

TEM Consulting LP Radial T Coil Probe Model No.: Radial T Coil Probe Serial No.: TEM-1130

I. D. No: 80579 Company: Pctest Engineering Lab.

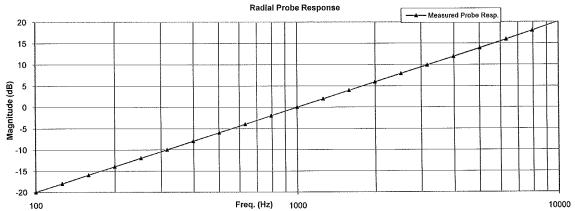
alibration results:			Before data:	After data	:
Probe Sensitivity measured wit	h Helmholi	z Coil			
Helmholtz Coll;			Before & after	er data same	:X
the number of turns on each coil;	10	No.			
the radius of each coil, in meters;	0.204	m	Laboratory Enviror	nment:	
the current in the coils, in amperes.;	0.08	Α	Ambient Temperature:	22.1	°C
Helmholtz Coll Constant;	6.98	A/m/V	Ambient Humidity:	30.8	% RH
Helmholtz Coil magnetic field;	5.90	A/m	Ambient Pressure:	100.1	kPa
			Calibration Date:	20-Jan-12	1:30 PM
Probe Sensitivity at	1000	Hz.	Re-calibration Due:	20-Jan-13	
was	-60.50	dBV/A/m	Report Number:	21559	-2
	0.944	mV/A/m	Control Number:	21559	
Probe resistance	903	Ohms			

,205342

This Calibration is traceable through NIST test numbers:

The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2

Graph represents Probes Frequency Response.



The above listed instrument was checked using calibration procedure documented in West Caldwell

Calibration Laboratories Inc. procedure:

Rev. 5.0 Sept. 10, 2010 Doc. # 1038 HCRTEMC

Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures

intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCSL Z540-1, (MIL-STD-45662A) and ISO 9001:2008, ISO 17025

Cal. Date: 20-Jan-2012 Calibrated on WCCL system type 9700

1:30 PM

Measurements performed by:

Felix Christopher

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Rev. 5.0 Sept. 10, 2010 Doc. # 1038 HCRTEMC

Page 1 of 2

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 31 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage 31 01 36

HCRTEMC_TEM-1130_Jan-20-2012

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564 Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Radial T Coil Probe

for Model No.: Radial T Coil Probe

Serial No.: TEM-1130

Company: Pctest Engineering Lab.

Test	Function	Tolera	Tolerance		Measured values		
			-	Before	Out	Remarks	
1.0	Probe Sensitivity at	1000 Hz.	dBV/A/m	-60.50			
			dB				
2.0	Probe Level Linearity		6	6.03			
	ŕ	Ref. (0 dB)	0	0.00			
			-6	-6.02			
			-12	-12.02		ļ	
			Hz				
3.0	Probe Frequency Response		100	-20.0		1	
			126	-18.0			
			158	-15.9			
			200	-13.9			
			251	-11.9			
			316	-10.0			
			398	-8.0			
			501	-6.0			
			631	-4.0			
			794	-2.0			
		Ref. (0 dB)	1000	0.0			
			1259	2.0			
			1585	4.0			
			1995	6.0			
			2512	7.9			
			3162	9.9			
			3981	11.9			
			5012	13.9			
			6310	15.9			
			7943	18.0			
			10000	20.1			

Instruments used for calibration	n:		Date of Cal.	Traceability No.	Due Date
HP HP	34401A	S/N US360641	17-Oct-2011	,205342	16-Oct-2012
HP	34401A	S/N US361024	17-Oct-2011	,205342	16-Oct-2012
İ HP	33120A	S/N S3604371	17-Oct-2011	,205342	16-Oct-2012
B&K	2133	S/N 1492410	4-Nov-2011	681/280411-11	4-Nov-2012
					1

Cal. Date: 20-Jan-2012

1:30 PM

Tested by: Felix Christopher

Calibrated on WCCL system type 9700

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Rev. 5.0 Sept. 10, 2010 Doc. # 1038 HCRTEMC

Page 2 of 2

FCC ID: ZNFLG530G	PCTEST*	HAC (T-COIL) TEST REPORT	(LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 32 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 32 01 36

11. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 33 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage 33 01 36

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FCC ID: ZNFLG530G	PCTEST*	HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 34 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		Fage 34 01 36

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FCC ID: ZNFLG530G	PCTEST	HAC (T-COIL) TEST REPORT		Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 35 of 38
0Y1205110681.ZNF	5/29/2012	Portable Handset		rage 33 01 36